## Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination | |
|---|---|---|
| 10/679,320 | LEE ET AL. | |
| **Examiner** | **Art Unit** | |
| Harold Kim | 2182 | |

| SEARCHED | | | |
|---|---|---|---|
| Class | Subclass | Date | Examiner |
| 710 | 2, 72, 300, 8, 36, 38 | 6/15/2005 | HK |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

| INTERFERENCE SEARCHED | | | |
|---|---|---|---|
| Class | Subclass | Date | Examiner |
| | | | |
| | | | |
| | | | |
| | | | |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|---|---|---|
| | DATE | EXMR |
| USPAT, USPGPUB, JPO, EPO, IEEE, NPL, PLUS, see attached search note, inventor search on eDAN | 6/15/2005 | HK |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |